


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583419	<b>Applicant(s)/Patent Under Reexamination</b>  HUBSCHWERLEN ET AL.
	<b>Examiner</b>  Rita J Desai	<b>Art Unit</b>  1625

SEARCHED			
Class	Subclass	Date	Examiner
546	23, 123, 156	1/14/2010	RD
514	290, 319, 320, 321,	1/14/2010	RD

SEARCH NOTES		
Search Notes	Date	Examiner
STN structure, file registry.	1/14/2010	Rd
Inventor search	1/14/2010	RD
west search	1/14/2010	RD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
546	23, 123, 156	11/18/2011	RD
514	290, 319, 320, 321	11/18/2011	RD

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